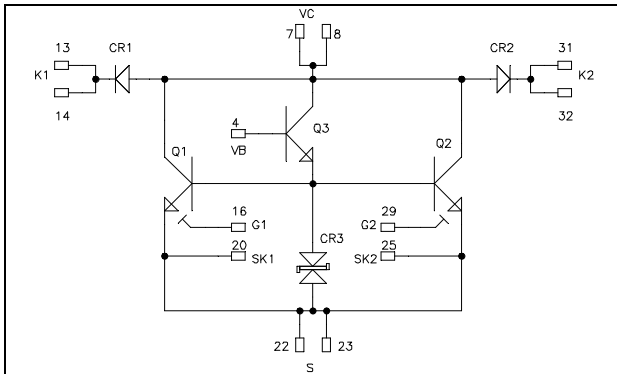


**Boost chopper
SiC FWD diode
ESBT® Power Module**

**$V_{CSS} = 1200V$
 $I_C = 80A @ T_C = 80^\circ C$**

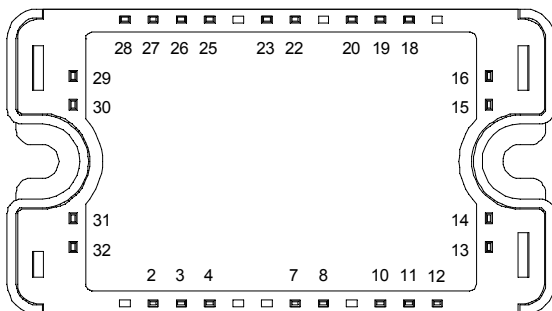


Application

- Power factor corrector

Features

- **Emitter Switched Bipolar Transistor® (ESBT®)**
 - Low saturation voltage
 - High voltage rating
 - Ultra fast switching speed
- **CR1 & CR2 SiC Schottky Diode**
 - Zero reverse recovery
 - Zero forward recovery
 - Temperature Independent switching behavior
 - Positive temperature coefficient on VF
- Very low stray inductance
- High level of integration



Pins 13/14/31/32 ; 22/23 ; 7/8 must be shorted together

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

All ratings @ $T_j = 25^\circ C$ unless otherwise specified

Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
V_{CSS}	Collector - Source Breakdown Voltage ($V_{GS} = V_{BS} = 0V$)	1200	V
V_{BSS}	Base - Source Breakdown Voltage ($V_{GS} = 0V$)	30	
V_{GS}	Gate - Source Voltage	± 20	V
I_C	Collector current	140*	A
I_B	Base current	4	
I_{BM}	Base peak current ($t_p < 1ms$)	5	
P_D	Maximum Power Dissipation (Q1 & Q2 in parallel)	$T_c = 25^\circ C$ 1390	W

* Specification of device but output current must be limited due to size of output pins.

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.
See application note APT0502 on www.microsemi.com

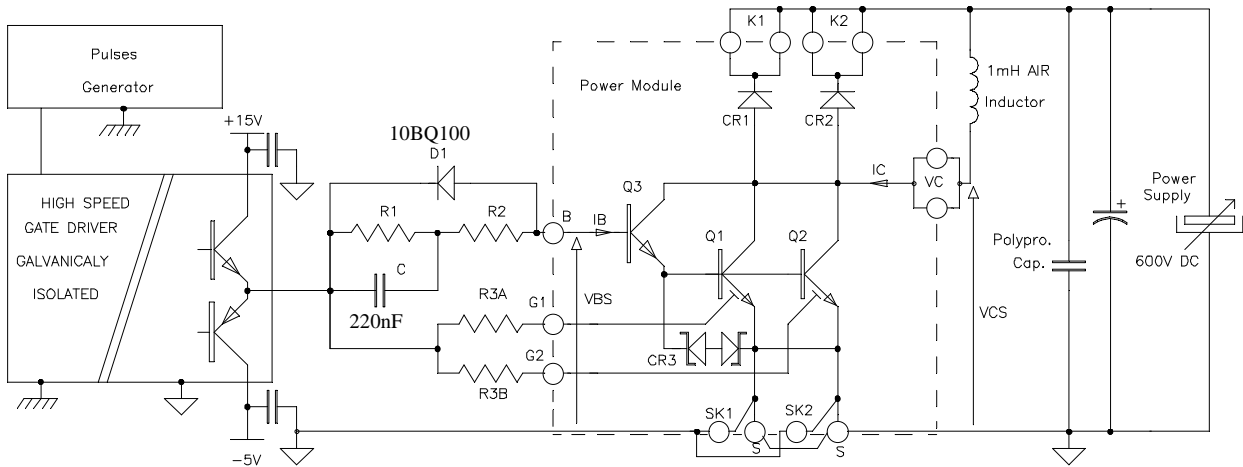


Fig 1: Electrical switching diagram

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$I_{CS(SS)}$	Collector Source current	$V_{BS} = V_{GS} = 0V$; $V_{CS(SS)} = 1200V$			300	μA
$I_{BS(OS)}$	Base Source current	$I_C = 0$, $V_{GS} = 0V$, $V_{BS(OS)} = 30V$			100	
$I_{G1Si(OS)}$	Gate Source leakage $i = 1, 2$	$V_{BS} = 0V$, $V_{G1Si} = \pm 20V$			5	
$V_{CS(ON)}$	Collector Source ON voltage	$V_{G1Sk1} = V_{G2Sk2} = 12V$ $I_C = 80A$, $I_B = 0.25A$		2.2		V
		$V_{G1Sk1} = V_{G2Sk2} = 12V$ $I_C = 80A$, $I_B = 1A$		1.2		
h_{FE}	DC current gain	$V_{G1Sk1} = V_{G2Sk2} = 10V$ $V_{CS} = 3V$, $I_C = 80A$		120		
$V_{BS(ON)}$	Base Source ON voltage	$V_{G1Sk1} = V_{G2Sk2} = 12V$ $I_C = 80A$, $I_B = 1.5A$		2.6		V
V_{BCL}	Base Clamping Voltage	$I_C = 80A$		8.5		V
$V_{G1Si(th)}$	Gate threshold voltage $i = 1, 2$	$V_{BS} = V_{GS}$, $I_B = 500\mu A$	2		4	V
C_{iss}	Input Capacitance	Per device Q1, Q2 $V_{CS} = 25V$; $V_{GS} = V_{CB} = 0V$ $f = 1MHz$		5.3		nF
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C) $V_{G1Sk1} = V_{G2Sk2} = 15V$ $V_{Bus} = 600V$; $I_D = 40A$ $R3A = R3B = 4.7\Omega$ $R1 = 25\Omega$; $R2 = 1\Omega$ (Fig 1)		101		ns
T_r	Rise Time			54		
$T_{d(off)}$	Turn-off Delay Time			943		
T_f	Fall Time			17		
E_{on}	Turn-on Switching Energy	Inductive switching @ 125°C $V_{G1Sk1} = V_{G2Sk2} = 15V$ $V_{Bus} = 600V$; $I_D = 40A$ $R3A = R3B = 4.7\Omega$ $R1 = 25\Omega$; $R2 = 1\Omega$ (Fig 1)		1.4		mJ
E_{off}	Turn-off Switching Energy			1.6		
E_{on}	Turn-on Switching Energy	Inductive switching @ 125°C $V_{G1Sk1} = V_{G2Sk2} = 15V$ $V_{Bus} = 600V$; $I_D = 40A$ $R3A = R3B = 4.7\Omega$ $R1 = 180\Omega$; $R2 = 0.5\Omega$ (Fig 1)		1.15		mJ
E_{off}	Turn-off Switching Energy			1.13		

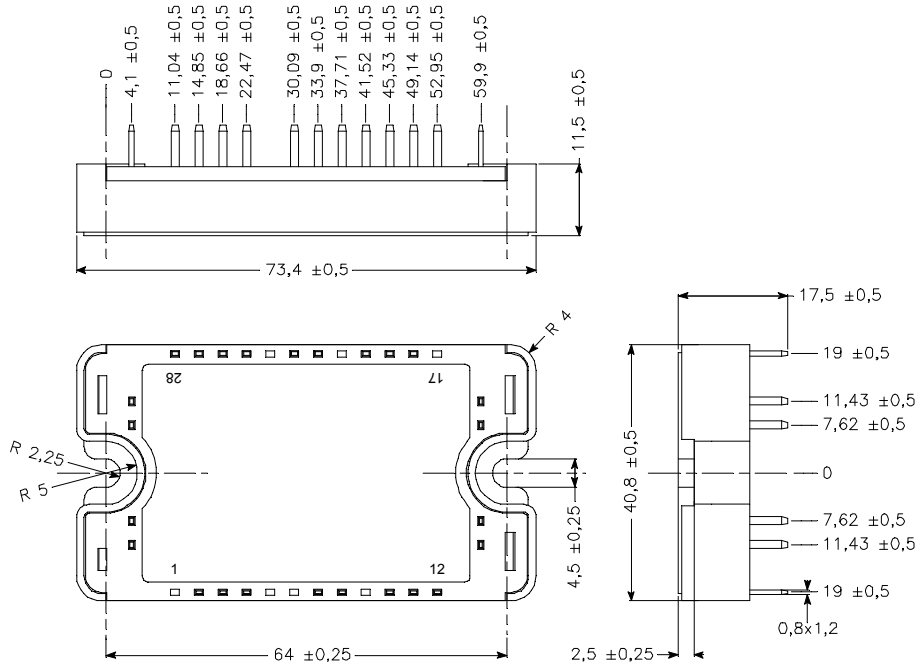
SiC diode ratings and characteristics (per leg CR1, CR2)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V _{RRM}	Maximum Peak Repetitive Reverse Voltage		1200			V
I _{RM}	Maximum Reverse Leakage Current	V _R =1200V		64	400	μA
				112	2000	
I _F	DC Forward Current			20		A
V _F	Diode Forward Voltage	I _F = 20A		1.6	1.8	V
				2.3	3	
Q _C	Total Capacitive Charge	I _F = 20A, V _R = 600V di/dt = 1000A/μs		80		nC
C	Total Capacitance	f = 1MHz, V _R = 200V		192		pF
		f = 1MHz, V _R = 400V		138		

Thermal and package characteristics

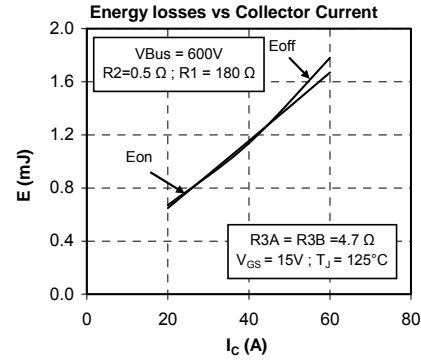
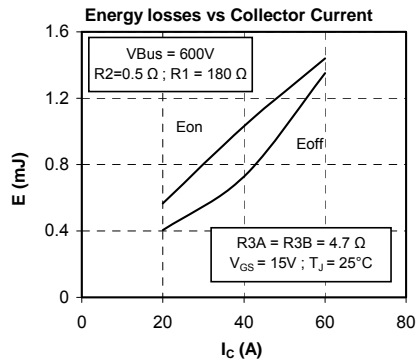
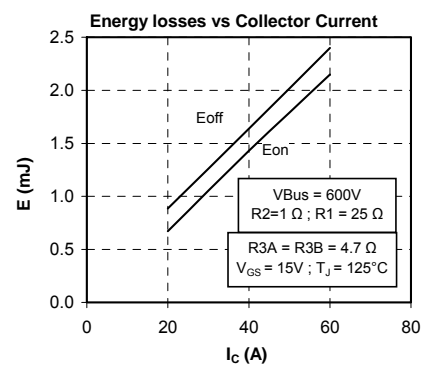
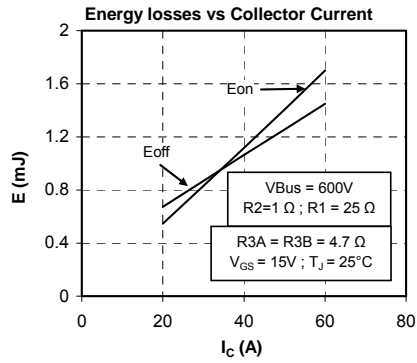
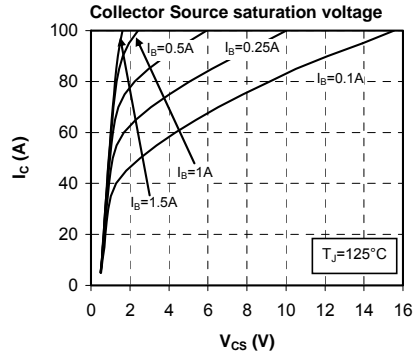
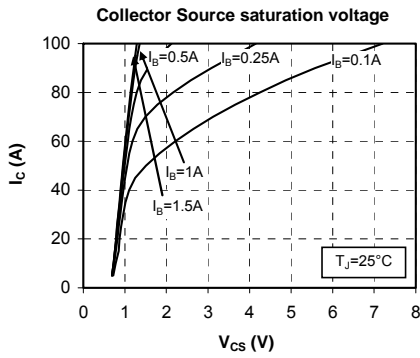
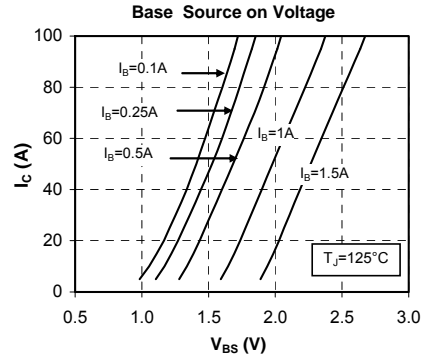
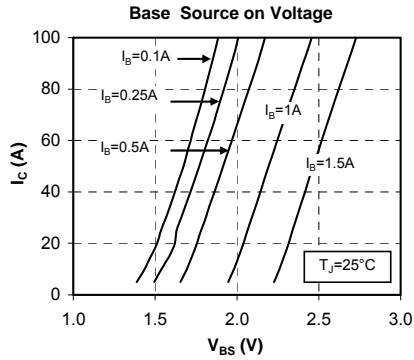
Symbol	Characteristic	Min	Typ	Max	Unit	
R _{thJC}	Junction to Case Thermal Resistance	Q1 & Q2 in parallel		0.09	°C/W	
		Per CR1, CR2 SiC Diode		1		
V _{ISOL}	RMS Isolation Voltage, any terminal to case t = 1 min, I _{isol} < 1mA, 50/60Hz	4000			V	
T _J	Operating junction temperature range	-40		150 [•]	°C	
T _{STG}	Storage Temperature Range	-40		150		
T _C	Operating Case Temperature	-40		100		
Torque	Mounting torque	To heatsink	M4	2.5	4.7	N.m
Wt	Package Weight				110	g

[•] T_J=175°C for SiC diodes

SP3 Package outline (dimensions in mm)


See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

Typical Performance Curve



Microsemi reserves the right to change, without notice, the specifications and information contained herein